

# Theoretical estimation of scattering loss rates in Cold-Atom traps for novel Ultra-High-Vacuum sensors

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A new pressure sensor for Ultra-High-Vacuum (UHV) has been built at the National Institute of Science and Technology (NIST)<sup>[1]</sup>. The development of these devices relies on ensembles of trapped and laser-cooled  ${}^7\text{Li}({}^2\text{S})$  or  ${}^{87}\text{Rb}({}^2\text{S})$  atoms at tens of micro-Kelvin temperature. The sensors will allow measurements of extremely low UHV pressures, for which current pressure sensors based on a hot wire are not reliable. Trapped cold atoms encounter residual room-temperature atomic and molecular gases in the vacuum system, which result in cold atom losses with near 100 % efficiency. One needs accurate knowledge of collisional rate coefficients to convert measured cold-atom loss rates into measurements of pressure. We present recent results<sup>[2]</sup> of quantum scattering calculations using high-quality *ab-initio* potentials computed with the current gold-standard coupled-cluster method. We find temperature-dependent elastic rate coefficients between cold atomic  ${}^7\text{Li}/{}^{87}\text{Rb}$  and room-temperature noble gases and molecular nitrogen and hydrogen. We also describe initial efforts on extending our calculations to  $\text{CO}({}^1\Sigma^+)$ ,  $\text{O}_2({}^3\Sigma_g^-)$  and also polyatomic molecules such as  $\text{CO}_2({}^1\Sigma^+)$ . Scattering calculations are performed by solving quantum close-coupling equations for all collision energies necessary to converge thermalized rate coefficients for temperatures up to room temperature. The computed loss-rates can be compared to experimental results obtained at NIST. We also estimate the uncertainties of the elastic rate coefficients associated with the uncertainty in the *ab-initio* potentials and due to omitted relativistic effects.

[1] L. Ehinger, B. Acharya, D. S. Barker, J. A. Fedchak *et al.* <https://arxiv.org/pdf/2204.03705.pdf>

[2] J. Kłos and E. Tiesinga, *J. Chem. Phys.* (2022); <https://doi.org/10.1063/5.0124062>

